## Application/Control No. Applicant(s)/Patent Under Reexamination 10/761,918 ATWATER ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 DuyVu n. Deo 1765 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,323,108 11-2001 438/458 Kub et al. Α US-7,019,339 03-2006 Atwater et al. 257/184 В С US-2005/0142879 06-2005 Atwater et al. 438/689 US-2005/0085049 04-2005 Atwater et al. 438/455 D US-6,251,754 06-2001 Ohshima et al. 438/506 Ε US-F US-G US-Н US-1 US-J US-K US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY N 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Х